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PATENT

Docket No. 81790.0119

Former Docket No. 005702-20068

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Continuation Application of:

Tomomi MOMOHARA

Serial No: Not yet assigned 09/511,620

Filed: February 23, 2000

For: SEMICONDUCTOR INTEGRATED
CIRCUIT DEVICE AND METHOD OF
TESTING THE SAME

Art Unit: 2784

Examiner: H. Nguyen

I hereby certify that this correspondence
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Dear Sir:

The undersigned hereby authorizes the following:

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located at JONES, TULLAR & COOPER, P.C., Suite 1002, 2001 Jefferson Davis Highway, Arlington, Virginia 22202, to inspect and make copies of the above-referenced patent application. The undersigned is an attorney of record.

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Respectfully submitted,

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